#### A Cross-Layer Approach for Diagnosing Storage System Failures

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Adam Manzanares, Filip Blagojevic, Cyril Guyot Western Digital Research

#### 1 Motivation

Diagnosing storage system failures is challenging even for professionals. One example is the "When Solid State Drives Are Not That Solid" incident occurred at Algolia data center, where a random subset of SSD based servers crashed for unknown reasons [5]. After looking into almost all software deployed, the engineers finally (mistakenly) concluded that Samsung SSDs were to blame. Samsung SSDs were criticized and blacklisted, until one month later a Linux kernel bug was identified as the root cause [4].

Similarly, Zheng *et al.* studied the behavior of SSDs under power fault [12]. The testing framework relied on the block I/O layer to apply workloads and check the behavior of devices. The initial experiments were performed on Linux kernel v2.6.32, and eight SSDs exhibited serialization failures [12]. However, in their follow-up work [13] where similar experiments were conducted on a newer kernel (v3.16.0), they observed that the failures symptoms on some SSDs changed significantly. The authors analysed hundreds of suspicious kernel patches and eventually confirmed that the different symptoms were caused by a Linux kernel bug [13].

The two cases above share a common mistake: people try to explain the behavior of SSDs *indirectly* through the OS kernel, with the (wrong) assumption that the kernel is correct. This is natural in practice as applications have to access the device via system calls. Also, SSDs are relatively young, and seems less trustable. We name such common practice as a *top-down indirect* approach. Nevertheless, both cases show that the kernel may play a role in causing system failures, while the device may be innocent. In fact, similar confusing and debatable failures are not uncommon [2,3,6]. With the system complexity increasing, the challenge of failure diagnoisis will likely increase too.

#### 2 Design & Implementation

To help diagnose storage system failures, we introduce a *cross-layer* approach called XDB. As shown in Figure 1a, XDB hosts the target storage software stack in a custom virtual ma-

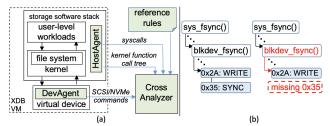


Figure 1: (a) Design Overview; (b) Example Result.

chine (VM). Similar to a classic bus analyzer [1], XDB captures the commands (e.g., SCSI, NVMe) transferred between the OS kernel and the storage device directly (via *DevAgent*)to help understand the interaction between the kernel and the device. Different from the bus analyzer, XDB leaverages virtualization to eliminate the dependence on special hardware (e.g., snooping cables) and the associated cost/inconvenience. Moreover, to help understand the high-level semantics and causal relation, XDB collects host-side functin calls (via HostAgent) and correlates events across layers and traces. XDB helps in two ways: (1) Combine events from different layers (i.e., host and device) into a cross-layer trace for analyzing the end-to-end system behavior; (2) Automatically identify potential problematic regions in the trace based on reference rules, which can be specified based on either domain knowledge (e.g., an fsync call should generate 0x35 SYNC commands in SCSI) or non-failure execution traces (e.g., due to different software versions or non-determinism).

#### 3 Preliminary Result

We have built a prototype of XDB based on QEMU [7] and applied it to diagnose 12 system failures caused by bugs in file systems, block layer, etc reported recently [8–11, 13]. We find that XDB is particularly helpful for understanding synchonrization issues where buggy functions lead to unexpected command sequences. Figure 1b shows the simplified result of diagnosing one of the aforementioned cases in section 1. By using the cross-layer traces, it is easy to see that the blkdev\_fsync in one execution (right-hand side) failed to generate a SYNC command at the device level.

#### References

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- [13] Mai Zheng, Joseph Tucek, Feng Qin, Mark Lillibridge, Bill W Zhao, and Elizabeth S. Yang. Reliability Analysis of SSDs under Power Fault. In *Proceedings of the* ACM Transactions on Computer Systems (TOCS'17), 2017.



## A Cross-Layer Approach for Diagnosing Storage System Failures

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# Motivation

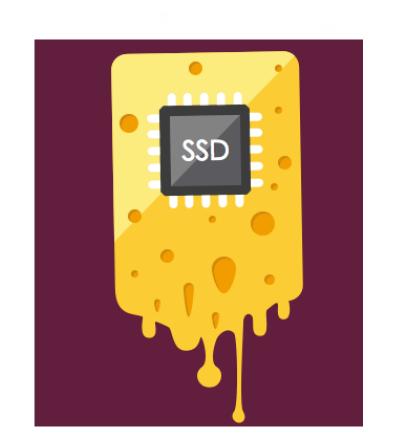
## Diagnosing storage system failures is challenging

- Complex software layers
  - e.g., databases, file systems, software RAID, ...
- Complex devices
  - e.g., flash-based solid state drives (SSDs),
- Complex cross-layer interactions/dependencies

### Example 1: "When SSDs are not that solid" [1]

- A random subset of SSD-based servers in Algolia datacenter crashed and corrupted files for unknown reasons
- Developers "spent a big portion of two weeks just isolating machines and restoring them as quickly as possible"
- Samsung SSDs were mistakenly blamed and blacklisted
- A month later a *Linux kernel bug* was identified as root cause

# **Ö** algolia



## Example 2: "Robustness of SSDs under Power Fault" [2][3]

- Zheng et al. studied behavior of SSDs under power fault
- Bypassed file system, but still relied on the block I/O layer to apply workloads
- Initial experiments were performed on Linux kernel v2.6.32,
   where 8 SSDs exhibited serialization errors
- A follow-up work on kernel v3.16.0 shows that the number of errors on some SSDs has reduced significantly
- A *Linux kernel bug* caused the different symptoms

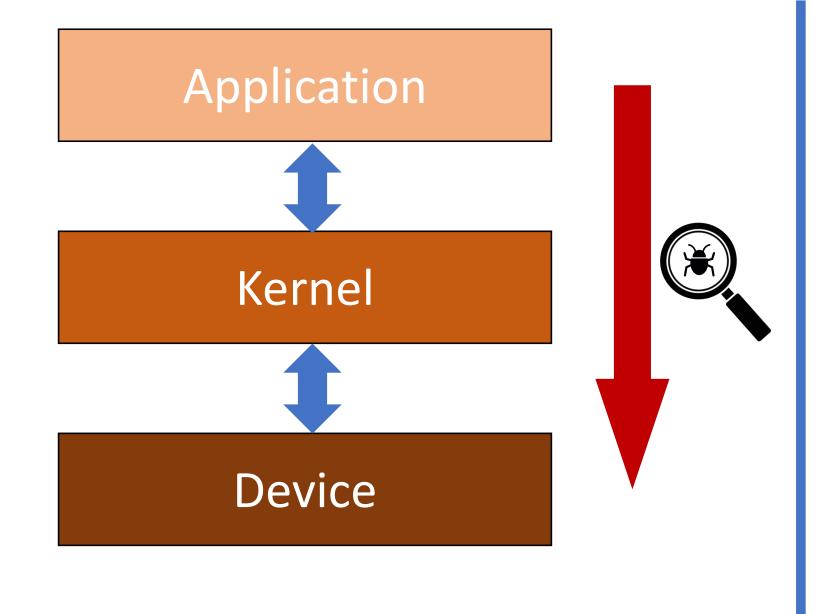
Kernel	SSD1	SSD2	SSD3	SSD4	SSD5
2.6.32	992	317	26	2	0
3.16.0	0	88	2	1	0

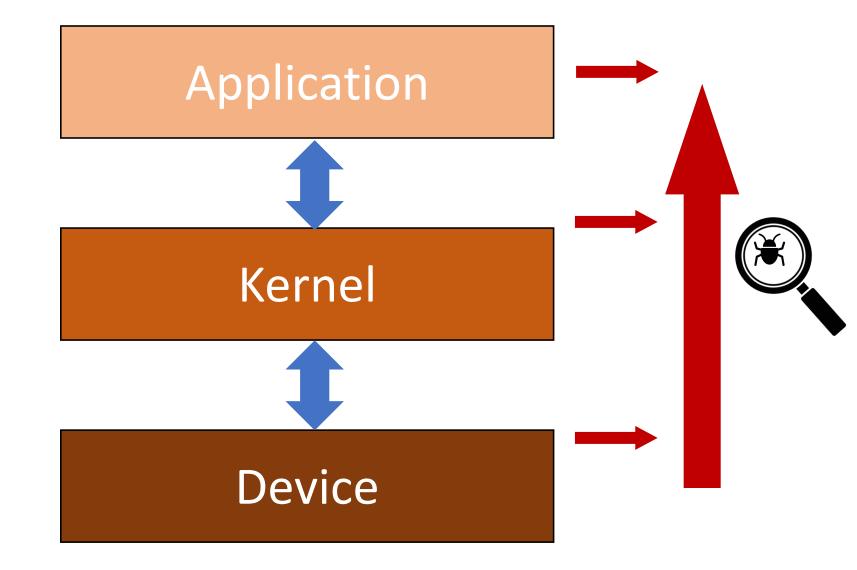
Table 1. SSDs behave differently under two kernels

### **COMMON MISTAKE**

infer the behavior of devices *indirectly* by *assuming that the kernel is correct* 

# Methodology





(a) Traditional diagnosis

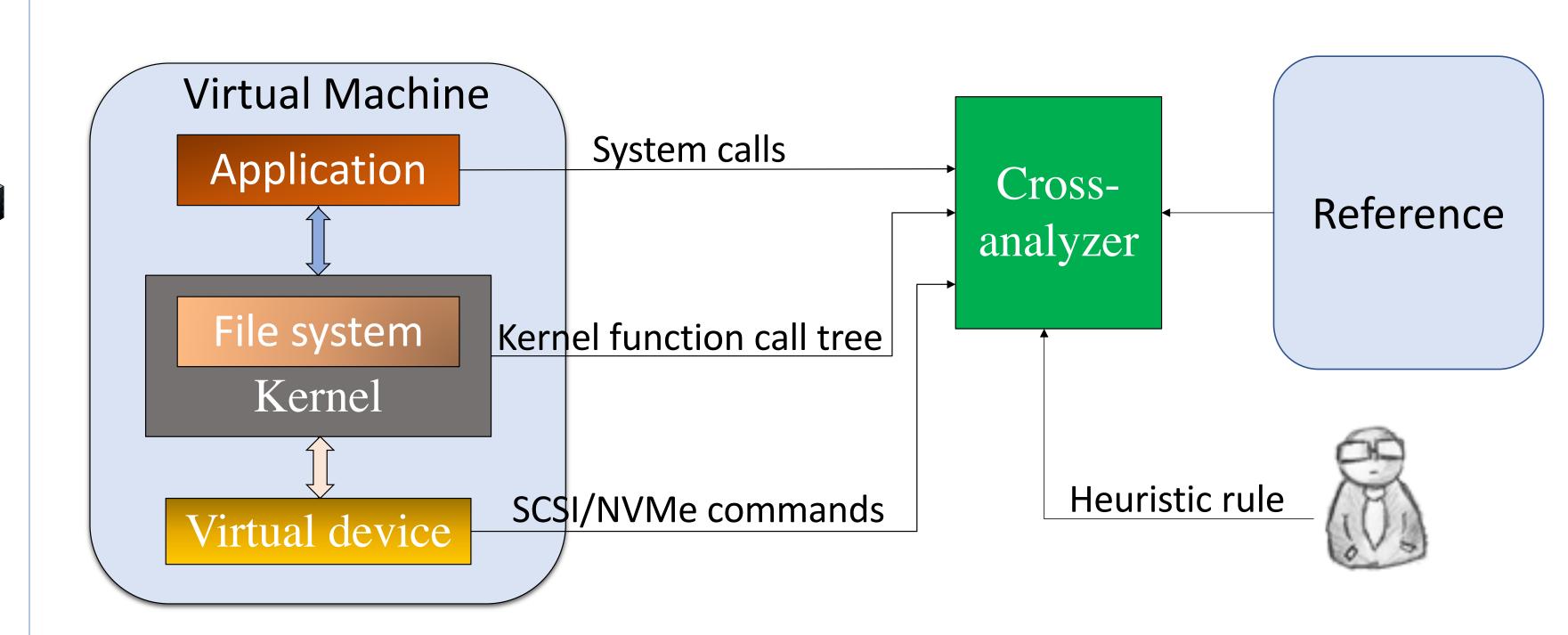
(b) Our approach

- Traditional diagnosis: a top-down approach
  - Infer the device behavior indirectly through kernel
  - trust the kernel more than the device

## Our approach

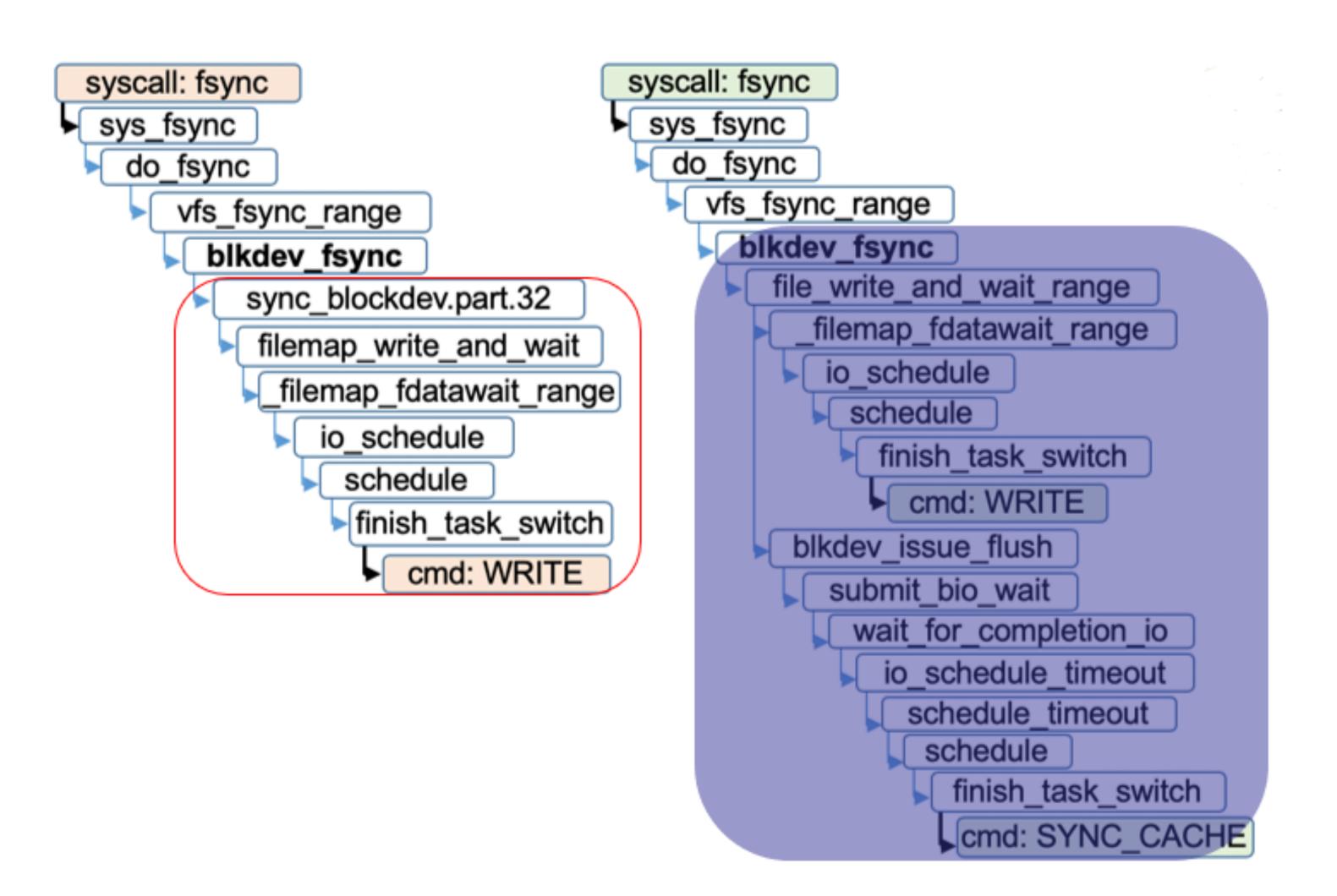
- collect device-level information directly
- leverage cross-layer differences to narrow down root cause

## Prototype



- Based on QEMU virtual machine
- Cross-layer tracing & delta debugging

# Preliminary Results



- Diagnose the kernel bug in [3]
  - Collect and corelate cross-layer trace
  - Pinpoint root cause by reference or heuristic rule

# **Acknowledgements**

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## References

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- [2] Mai Zheng, Joseph Tucek, Feng Qin, and Mark Lillibridge. Understanding the robustness of SSDs under power fault. In Proceedings of the 11<sup>th</sup> USENIX Conference on File and Storage Technologies (FAST), 2013.
- [3] Mai Zheng, Joseph Tucek, Feng Qin, Mark Lillibridge, Bill W Zhao, and Elizabeth S. Yang. Reliability Analysis of SSDs under Power Fault. In Proceedings of the ACM Transactions on Computer Systems (TOCS), 2017.



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Data Storage Lab

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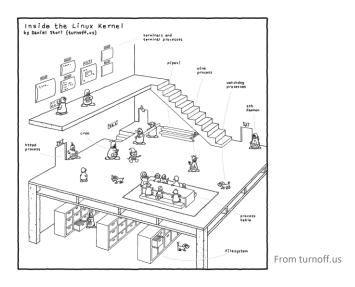


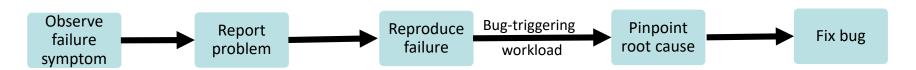
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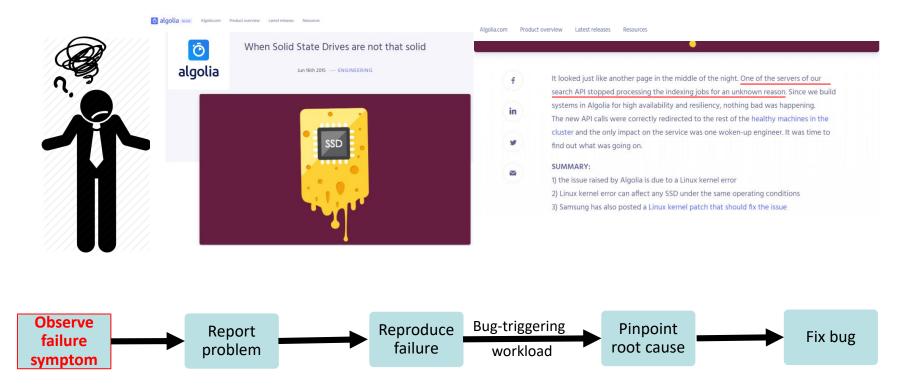


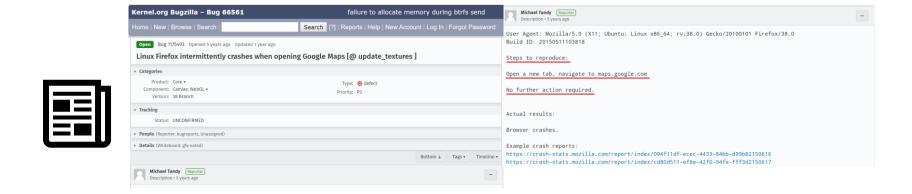
#### Storage System Failures Are Damaging

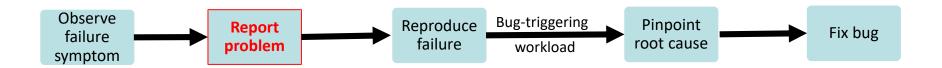






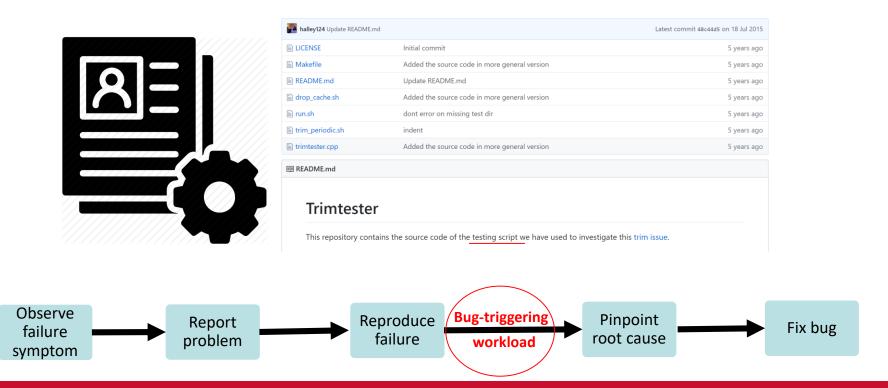


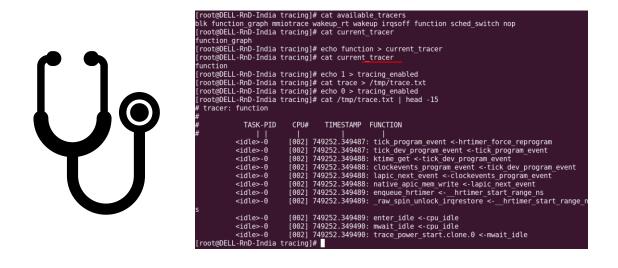


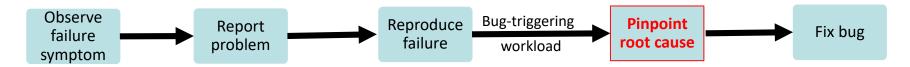












#### [PATCH] raid0: data corruption when using trim

[Date Prev][Date Next][Thread Prev][Thread Next][Date Index][Thread Index]

- To: neilb@xxxxxxx
- Subject. [PATCH] raid0: data corruption when using trim
- Date: Sun, 19 Jul 2015 12:28:16 +0900
- Cc. linux-raid@xxxxxxxxxxxxxxxx
- Dlp-filter. Pass
- Thread-index. AdDB0p+sh1bJ7soiSea9KclweqiZPg==

[?0001-PATCH-raid0-data-corruption-when-using-trim.patch?]

>From ca7dbe01fcd2ef2f8cea1a38de5aca5c866c585d Mon Sep 17 00:00:00 2001 From: Seunguk Shin <seunguk.shin@xxxxxxxxxx>

Date: Sat, 18 Jul 2015 20:13:44 +0900

Subject: [PATCH] [PATCH] raidO: data corruption when using trim

When we are using software raid and tirm, there is data corruption.

The raid driver lets split bios share bio vector of source bio. The scsi/ata driver allocates a page and stores that pointer on bio->bi io vec->bv page

(sd\_setup\_discard\_mmd) because the scsi/ata needs some payloads that include start address and size of device to trim.

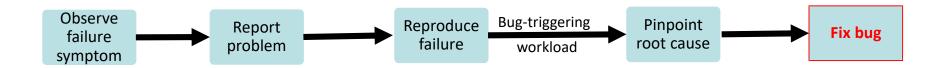
Because split bios share the source bio's bi io vec,

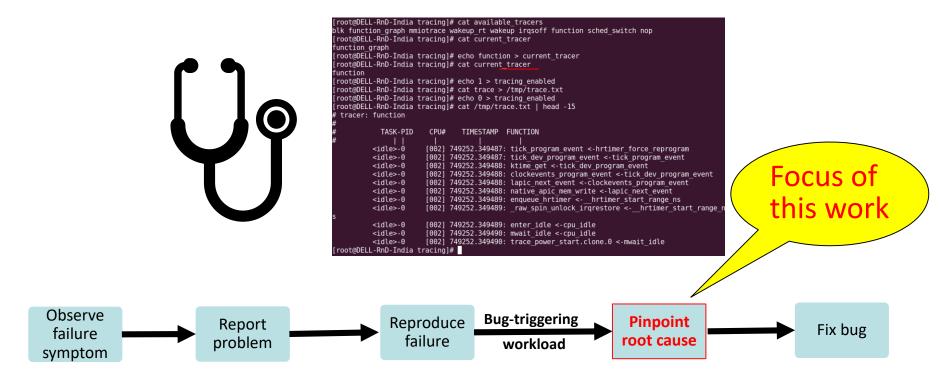
the pointer to the allocated page in scsi/ata driver is overwritten.

This patch splits bio vector if bio is discard.

block/bio.c | 6 ----drivers/md/raid0.c | 13 ++++++++++ include/linux/bio.h | 6 ++++++

3 files changed, 19 insertions(+), 6 deletions(-)

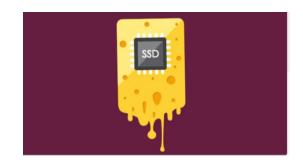


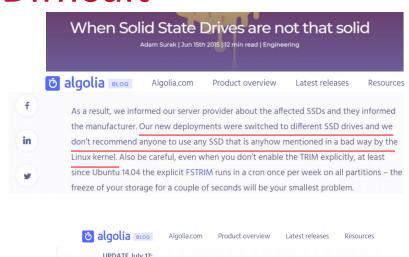


#### Pinpointing Root Cause Is Difficult

- E.g., Algolia case:
  - The symptom disappear after changing to other brand SSDs
  - Samsung SSDs were mistakenly blamed and blacklisted
  - A month later, a Linux kernel bug was identified as root cause

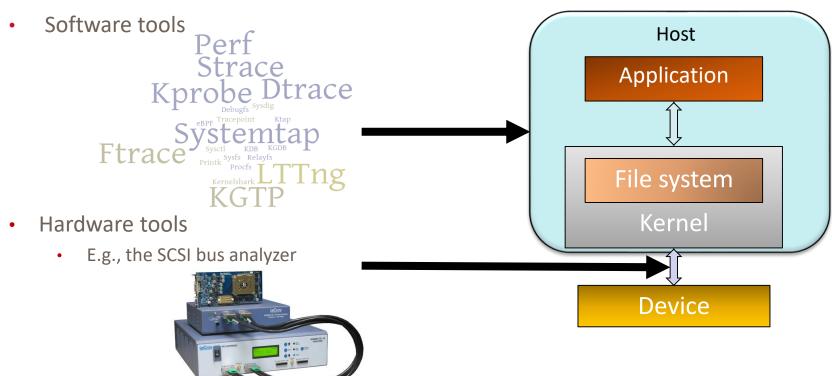




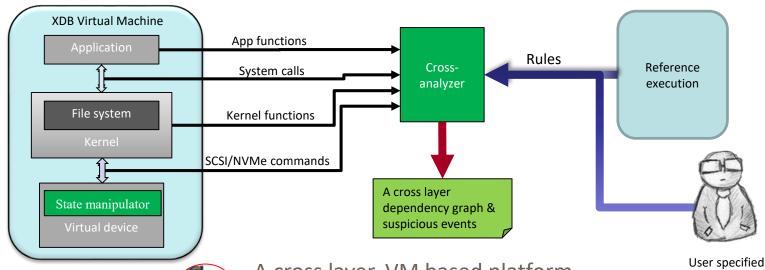




### **Existing Tools**



#### Our Approach: XDB



A cross layer, VM based platform

- Support unmodified software stack
- Do not require special hardware
- Identify anomaly automatically

### **Key Challenges**



1. How to synchronize events precisely across layers?



2. How to trace fine-grained functions?



3. How to define rules?



4. How to minimize disturbance and overhead?

#### **Preliminary Results**

- A prototype based on QEMU
  - Trace system calls
  - Trace kernel functions (partial)
  - Trace NVMe and SCSI commands
- Reproduced failure cases from literature
- Experiment setting:
  - Intel Xeon 3.00GHz CPU
  - 16GB main memory
  - Two WD5000AAKS hard disks.
  - Ubuntu 16.04 LTS with kernel v4.4



- Failure symptom
  - Zheng et. al. [1] studied the SSDs' behavior under power fault on Linux kernel v2.6.32
    - Applied workload & measured behavior via the block layer
  - Many serialization errors observed on different SSDs
  - The root cause is unclear

Failure	Seen?	Devices exhibiting that failure	
Bit Corruption	Y	SSD#11, SSD#12, SSD#15	
Flying Writes	N	-	
Shorn Writes	Y	SSD#5, SSD#14, SSD#15	
Unserializable Writes	Inserializable Writes Y SSD#2, SSD#4, SSD#7, SSD#8, SSD#9, SSD#		
Metadata Corruption	Y	SSD#3	
Dead Device	Y	SSD#1	
None	Y	SSD#6, SSD#10, HDD#2	

Table 5: Summary of observations. "Y" means the failure was observed with any device, while "N" means the failure was not observed.

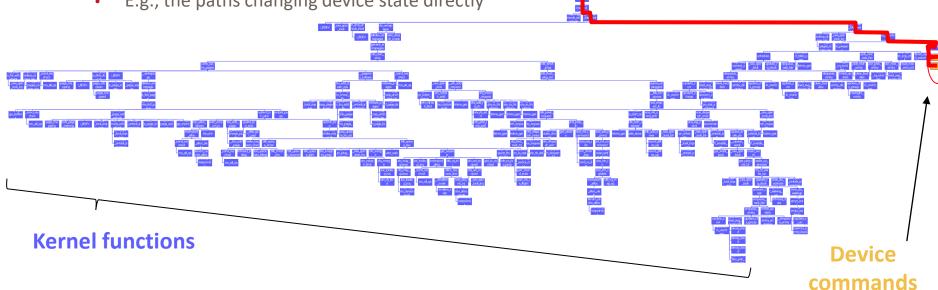
<sup>[1]</sup> Understanding the Robustness of SSDs under Power Fault (FAST'13)

## Syscall Case Study A cross layer dependency graph from XDB Help understand full stack activities Show cross layer correlations **Kernel functions**

**Device** 

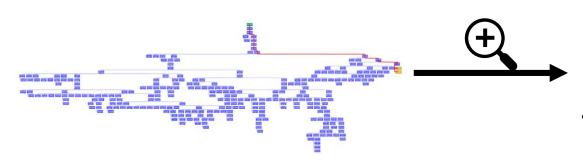
commands

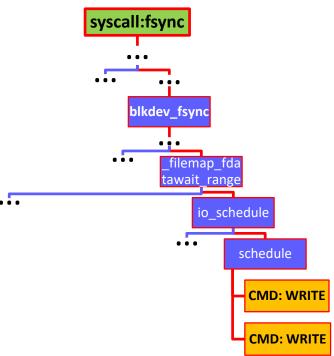
- A cross layer dependency graph from XDB
- Suspicious paths
  - E.g., the paths changing device state directly



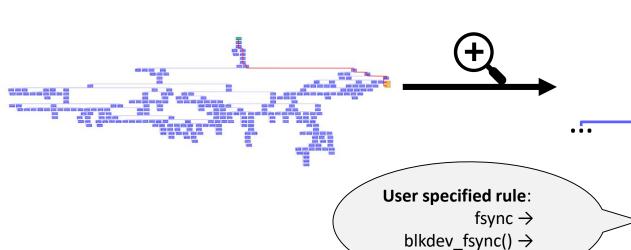
**Syscall** 

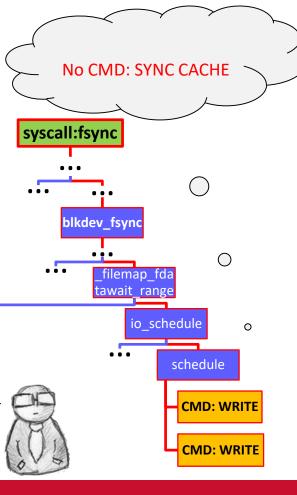
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CMD: SYNC CACHE

- Recap failure symptom
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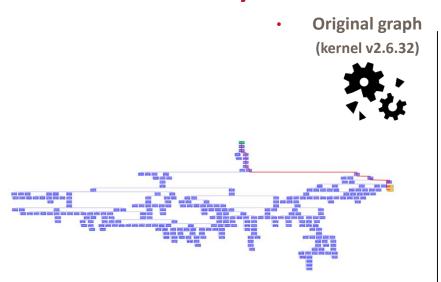
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[1] Understanding the Robustness of SSDs under Power Fault (FAST'13)

- New symptom
  - Zheng et. al. [2] repeated the experiment on kernel v3.16.0
  - The no. of serialization errors reduce on the new kernel

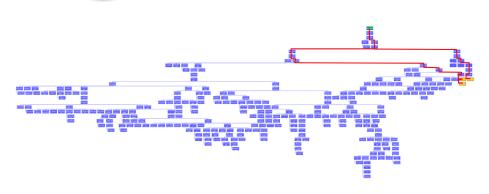
	Number of serialization errors				
Kernel	SSD1	SSD2	SSD3	SSD4	SSD5
v2.6.32	992	317	26	2	0
v3.16.0	0	88	2	1	0

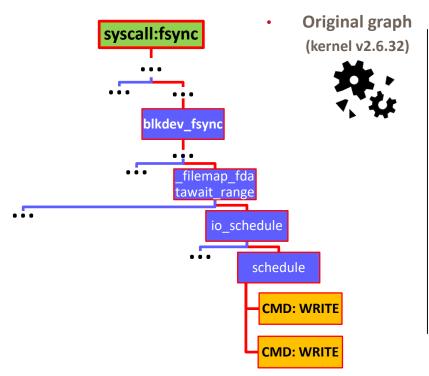
[2] Reliability Analysis of SSDs under Power Fault (TOCS'17)

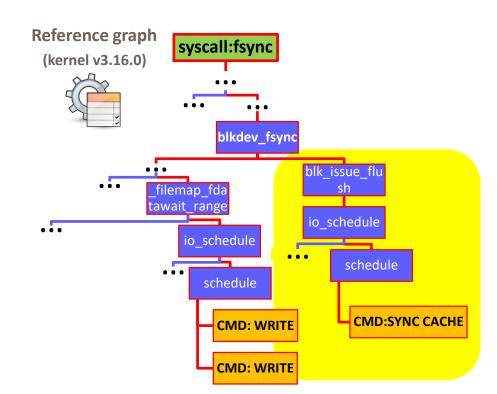


• Reference graph
(kernel v3.16.0)









Thanks!
Questions?

